



100V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on)}	I _D T _A = 25°C
100V	0.25Ω	1.9A

Description and Applications

This MOSFET utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed, this makes it ideal for high efficiency power management applications.

- DC-DC Converters
- Power management functions
- Disconnect Switches
- Motor control



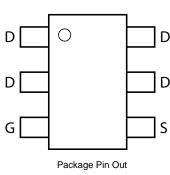
- Low on-resistance
- Fast switching speed
- Qualified to AEC-Q101 Standards for High Reliability

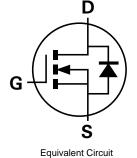
Mechanical Data

- Case: SOT23-6
- Case Material: Molded Plastic, UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Matte Tin Finish annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 🚳
- Weight: 0.015 grams (approximate)



TOP VIEW



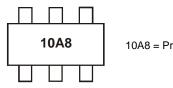


Equivalent Oriou

Ordering Information

Product	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXMN10A08E6TA	7	8	3,000
ZXMN10A08E6TC	13	8	10,000

Marking Information



10A8 = Product Type Marking Code



Maximum Ratings @T_A = 25°C unless otherwise specified

Characteristic Drain-Source voltage		Symbol	Value	Unit	
		V _{DSS}	100	V	
Gate-Source voltage		V _{GS}	±20	V	
Continuous Drain current	V _{GS} = 10V	(Note 2) T _A = 70°C (Note 2) (Note 1)	ID	1.9 1.5 1.5	А
Pulsed Drain current (Note 3)		I _{DM}	8.6	А	
Continuous Source current (Body diode) (Note 2)		I _S	2.5	А	
Pulsed Source current (Body diode) (Note 3)		I _{SM}	8.6	А	

Thermal Characteristics

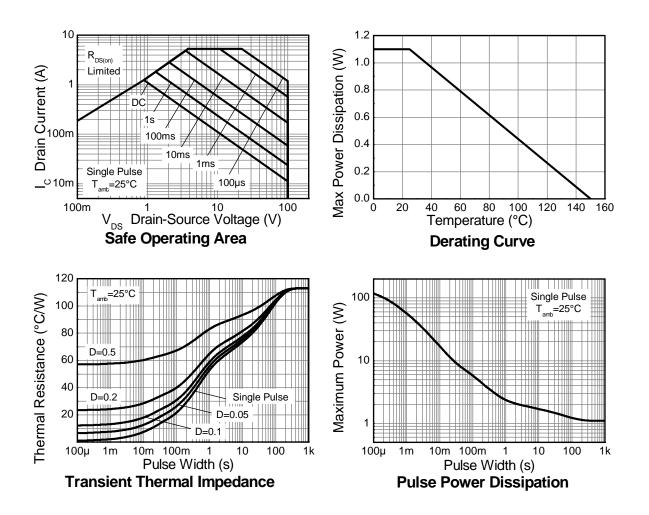
Characteristic		Symbol	Value	Unit
Power dissipation Linear derating factor	(Note 1)	5	<u> </u>	W mW/°C
Power dissipation Linear derating factor	(Note 2)	P _D	1.7 13.6	W mW/°C
Thermal Resistance, Junction to ambient	(Note 1) (Note 2)	R _{0JA}	113 73	°C/W
Operating and storage temperature range		T _J , T _{STG}	-55 to 150	°C

1. For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions. Notes:

2. For a device surface mounted on FR4 PCB measured at t \leq 5 sec. 3. Repetitive rating 25mm x 25mm FR4 PCB, D = 0.02, pulse current 300µs - pulse width limited by maximum junction temperature. Refer to Transient Thermal Impedance graph



Thermal Characteristics





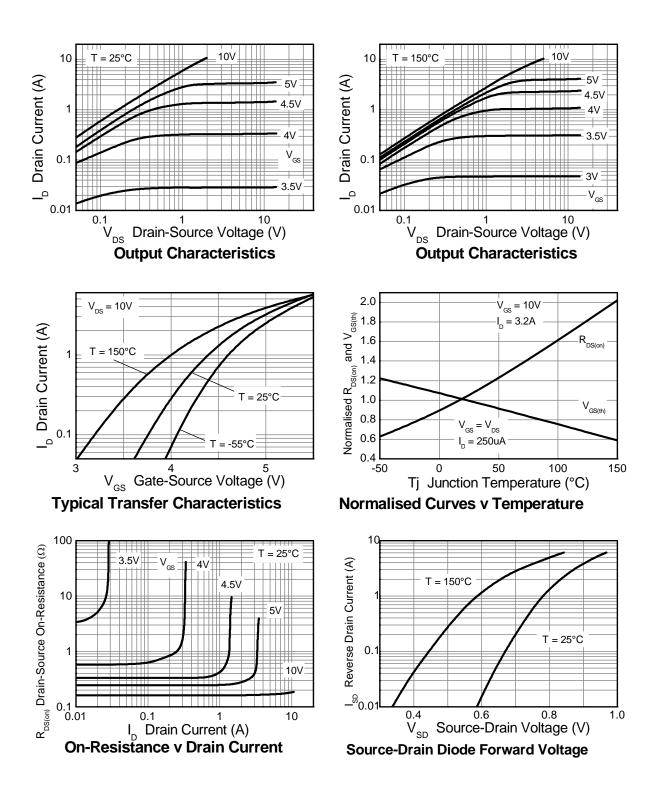
Electrical Characteristics @T _A = 25°C unless otherwise specified							
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	V _{(BR)DSS}	100			V	$I_D = 250 \mu A, V_{GS} = 0V$	
Zero Gate Voltage Drain Current	I _{DSS}			0.5	μA	V_{DS} = 100V, V_{GS} = 0V	
Gate-Source Leakage	I _{GSS}	_		±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(th)}	2		4	V	$I_D = 250 \mu A, V_{DS} = V_{GS}$	
Static Drain-Source On-Resistance (Note 4)	R _{DS (ON)}	_	_	0.25 0.30	Ω	$V_{GS} = 10V, I_D = 3.2A$	
Forward Transconductance (Notes 4 & 6)	g _{fs}	_	5.0	0.30	S	$V_{GS} = 6V, I_D = 2.6A$ $V_{DS} = 15V, I_D = 3.2A$	
Diode Forward Voltage (Note 4)	V _{SD}	_	0.87	0.95	V	$I_{\rm S} = 3.2 {\rm A}, V_{\rm GS} = 0 {\rm V}$	
Reverse recovery time (Note 6)	t _{rr}	_	27	_	ns		
Reverse recovery charge (Note 6)	Q _{rr}	_	32	_	nC	$I_F = 1.2A$, di/dt = 100A/µs	
DYNAMIC CHARACTERISTICS (Note 6)				•			
Input Capacitance	C _{iss}		405		pF		
Output Capacitance	C _{oss}		28.2		pF	V _{DS} = 50V, V _{GS} = 0V f = 1MHz	
Reverse Transfer Capacitance	C _{rss}		14.2		pF		
Total Gate Charge	Qg	_	4.2	_	nC	$V_{DS} = 50V, V_{GS} = 5V$ $I_D = 1.2A$	
Total Gate Charge	Qg	_	7.7		nC		
Gate-Source Charge	Q _{gs}	_	1.8		nC	$V_{DS} = 50V, V_{GS} = 10V$ $I_{D} = 1.2A$	
Gate-Drain Charge	Q _{gd}	_	2.1		nC	U = 1.2A	
Turn-On Delay Time (Note 5)	t _{D(on)}	_	3.4		ns		
Turn-On Rise Time (Note 5)	tr		2.2		ns	V _{DD} = 30V, V _{GS} = 10V	
Turn-Off Delay Time (Note 5)	t _{D(off)}		8		ns	$I_D = 1.2A, R_G \cong 6.0\Omega$	
Turn-Off Fall Time (Note 5)	tf	_	3.2	_	ns	1	

Notes: 4. Measured under pulsed conditions. Pulse width $\leq 300 \mu s;$ duty cycle $\leq 2\%$

Switching characteristics are independent of operating junction temperatures.
 For design aid only, not subject to production testing.

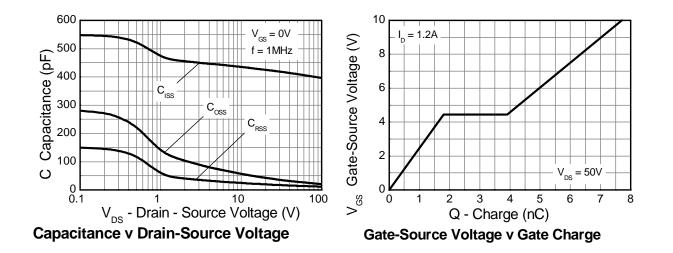


Typical Characteristics

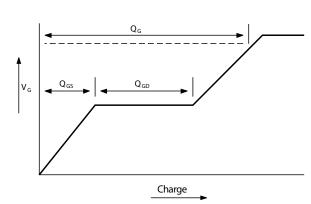




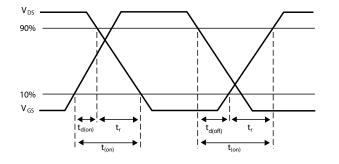
Typical Characteristics - continued



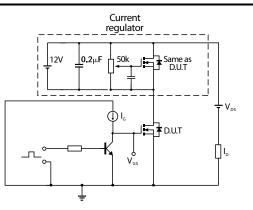
Test Circuits



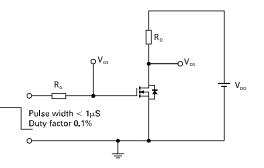
Basic gate charge waveform



Switching time waveforms



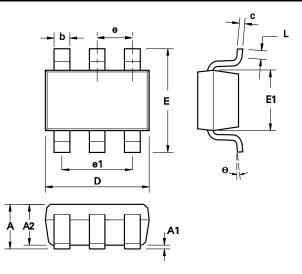
Gate charge test circuit



Switching time test circuit

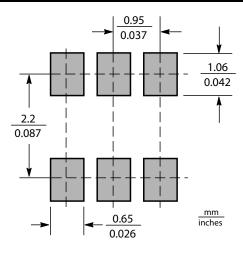


Package Outline Dimensions



DIM	Millim	neters	Inches		
	Min.	Max.	Min.	Max.	
A	0.90	1.45	0.35	0.057	
A1	0.00	0.15	0	0.006	
A2	0.90	1.30	0.035	0.051	
b	0.35	0.50	0.014	0.019	
С	0.09	0.20	0.0035	0.008	
D	2.80	3.00	0.110	0.118	
E	2.60	3.00	0.102	0.118	
E1	1.50	1.75	0.059	0.069	
L	0.10	0.60	0.004	0.002	
е	0.95 REF		0.037 REF		
e1	1.90 REF		0.074 REF		
L	0°	10°	0°	10°	

Suggested Pad Layout





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